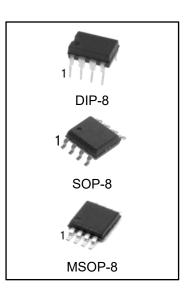


CMOS general purpose timer

Features

- Exact equivalent in most cases for SE/NE555.
- Low Supply Current.
- High speed operation 500 kHz guaranteed.
- Wide operation supply voltage range 2 to 18 volts.
- Timing from microseconds through hours.
- Operates in both astable and monostable modes.
- Adjustable duty cycle.
- High output source/sink driver can drive TTL/CMOS



Ordering Information

DEVICE	Package Type	MARKING	Packing	Packing Qty
TLC555PG	DIP-8	TLC555	TUBE	2000pcs/box
TLC555DRG	SOP-8	TLC555	REEL	2500pcs/reel
TLC555DGKRG	MSOP-8	C555	REEL	3000pcs/reel

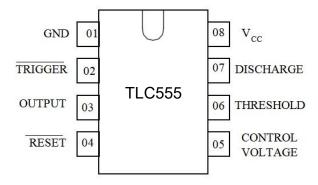


General Description

The TLC555 is CMOS RC timers providing significantly improved performance over the standard SE/NE555 and 355 timers, while at the same time being direct replacements for those devices in most applications. Improved parameters include low supply current, wide operating supply voltage range, low THRESHOLD, TRIGGER and RESET currents, no crowbarring of the supply current during output transitions, higher frequency performance and no requirement to decouple CONTROL VOLTAGE for stable operation.

Specifically, the TLC555 is stable controller capable of producing accurate time delays of frequencies.

Pin Assignment



Truth Table

THRESHOLD	TRIGGER	RESET	OUTPUT	DISCHARGE
X	X	L	L	ON
> 2/3 V _{CC}	> 1/3 V _{CC}	Н	L	ON
< 2/3 V _{CC}	> 1/3 V _{CC}	Н	STABLE	STABLE
Х	< 1/3 V _{CC}	Н	Н	OFF



Maximum Ratings And Recommended Operating Conditions

		Recomn operating c		Maximum ratings		
Parameter, unit	Symbol	Val	ue	Val	ue	
		min	max	min	max	
Supply Voltage, V	VCC	2.0	18.0	0	18.0	
Output Current, mA	Io	-	20	-	100	
Input Voltage, V	VTH, VTRIG, VRST	-	-	-0.3	V _{CC} +0.3	
Power Dissipation, mW	P _D	-	-	-	200	
Operating Temperature,°C	TOPR	-40	85	-40	85	
Storage Temperature,°C	TSTG	-	-	-65	150	
Lead Temperature, 1 mm from Case for 10 Seconds, °C	TSOLDER	-	-		245	

Note: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured.



Dc Electrical Characteristics (Voltages Referenced to GND)

Dc Electrical Chara	<u>acteristics (</u>	Voltages Reference	ced to GN	D)		
Danamatan umita	Compale al	Test Condit	ions	Val	Tempe-	
Parameter, units	Symbol	IOL, IOH	VCC, B	min	max	rature, °C
Threshold Voltage, V	VTH		5.0	0.65 V _{CC}	0.70 V _{CC}	25±10
Threshold voltage, v	VIП		5.0	0.60 V _{CC}	0.80 V _{CC}	-20, 70
Trigger voltage, V	VTRIG		5.0	0.31 V _{CC}	0.36 V _{CC}	25±10
Trigger voitage, v	VIKIG		5.0	0.28 V _{CC}	0.40 V _{CC}	-20, 70
			2.0	0.4	1.0	25±10
Reset voltage, V	VRST		18.0	0.4	1.0	23 ± 10
Neset voltage, v	VIXOI		2.0	0.2	1.5	-20, 70
			18.0	0.2	1.5	-20, 70
Control Voltage Lead, V	VCV			0.65 V _{CC}	0.69 V _{CC}	25 10
Control voltage Leau, v				0.60 V _{CC}	0.80 V _{CC}	-20, 70
	VoL	$I_{OL} = 3.2 \text{ mA}$	5.0		0.4	25±10
Output voltage Low, V		I _{OL} = 20 mA	15.0		1.0	23 ± 10
Output voltage Low, v		I _{OL} = 3.2 mA	5.0		0.6	-20, 70
		I _{OL} = 20 mA	15.0		1.5	-20, 70
			5.0	4.0		25±10
Output voltage High, V	Vон	I _{OH} = -0.8 mA	15.0	14.3		23 ± 10
Output voltage High, v	۷ОП	юн – -0.6 ПТА	5.0	3.5		-20, 70
			15.0	14.0		-20, 70
			2.0		200	25±10
Supply Current, µA	ICC		18.0		300	ZJ <u> </u> 10
Зарріу Сапепі, рА	100		2.0		400	-20, 70
			18.0		600	-20, 10



Ac Electrical Characteristics

		Test Conditions	Va	Tempe-		
Parameter, unit	Symbol	R _L , C _L	VCC, V	Min	Max	rature, °C
Rise (Fall) Time of	tTHL,	$R_L = 10 \text{ M}\Omega, C_L = 10 \text{ pF}$	5.0	35	75	25±10
Output,ns	tTLH	, - ,		70	150	-20, 70
Guaranteed Max	fMAX	Astable Operation	2.0-	500		25±10
Osc Freq,kHz		'	18.0	200		-20, 70
Initial accuracy, %				5		
Drift with Tomporature			5.0		0.02	
Drift with Temperature,	αf	R∟ = 1 - 100 kΩ	10.0		0.03	-20, 70
70/ 0		C∟= 0.1 µF	15.0		0.06	
Drift with Supply Voltage,	Δf		5 0		3	25±10
%/B	ΔΙ		5.0	·	6	-20, 70

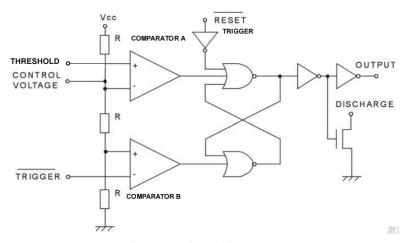


Figura 1. Block Diagram

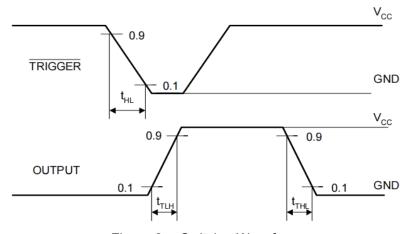
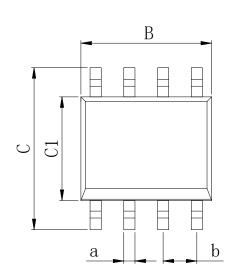


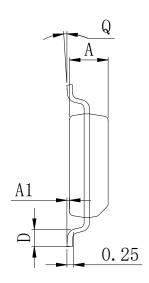
Figura 2. Switcing Waveforms



Physical Dimensions

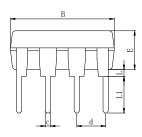
SOP-8



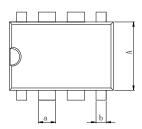


Dimensions In Millimeters(SOP-8)										
Symbol:	Α	A1	В	С	C1	D	Q	а	b	
Min:	1.35	0.05	4.90	5.80	3.80	0.40	0°	0.35	1.27 BSC	
Max:	1.55	0.20	5.10	6.20	4.00	0.80	8°	0.45	1.27 650	

DIP-8





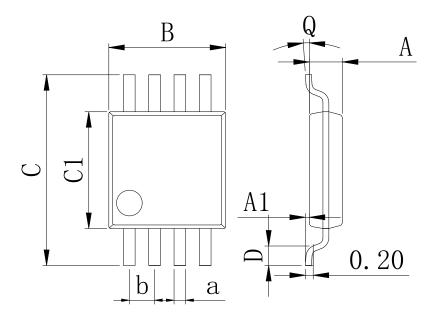


Dimensions In Millimeters(DIP-8)											
Symbol:	Α	В	D	D1	Е	L	L1	а	b	С	р
Min:	6.10	9.00	8.10	7.42	3.10	0.50	3.00	1.50	0.85	0.40	2 E4 BCC
Max:	6.68	9.50	10.9	7.82	3.55	0.70	3.60	1.55	0.90	0.50	2.54 BSC



Physical Dimensions

MSOP-8



Dimensions In Millimeters(MSOP-8)										
Symbol:	Α	A1	В	С	C1	D	Q	а	b	
Min:	0.80	0.05	2.90	4.75	2.90	0.35	0°	0.25	0.65 BSC	
Max:	0.90	0.20	3.10	5.05	3.10	0.75	8°	0.35	0.00 BSC	



Revision History

DATE	REVISION	PAGE		
2015-3-6	New	1-9		
2022 0 44	Update encapsulation type、Update Lead Temperature、Updated DIP-8 dimension、	1, 3, 6		
2023-9-14	Add annotation for Maximum Ratings.			



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